

<b>Notice of References Cited</b>	Application/Control No. 10/789,390	Applicant(s)/Patent Under Reexamination CROWLEY, ROBERT JOSEPH	
	Examiner John D. Lee <i>John D. Lee</i>	Art Unit 2874	Page 1 of 1

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*	B	US-6,258,401	07-2001	Crowley, Robert Joseph	427/126.3
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*	D	US-6,700,550	03-2004	Crowley, Robert Joseph	343/792.5
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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Poncharal et al, "Electrostatic Deflections and Electromechanical Resonances of Carbon Nanotubes", SCIENCE, vol. 283, 05 March 1999, pages 1513-1516.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.